
**Optics and photonics —
Measurement method of
semiconductor lasers for sensing**

Optique et photonique — Méthode de mesure des lasers semi-conducteurs pour la sensibilité





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CP 401 • Ch. de Blandonnet 8
CH-1214 Vernier, Geneva
Phone: +41 22 749 01 11
Fax: +41 22 749 09 47
Email: copyright@iso.org
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Published in Switzerland